

Notice of References Cited		Application/Control No. 10/019,693	Applicant(s)/Patent Under Reexamination KOIZUMI ET AL.	
		Examiner Sudhaker B. Patel, D.Sc.Tech.	Art Unit 1624	Page 1 of 1

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	W	
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U	Chemical abstract DN 119:249709, also cited as USP5192785.
V	Chemical Abstract DN115:255820, also cited as 5025031.
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¹ A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.